

### **Data Sheet**

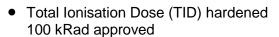
### BUY15CS45B-01

### **HiRel** RadHard Power-MOS

- Low R<sub>DS(on)</sub>
- Single Event Effect (SEE) hardened

LET 55, Range: 95µm (Xe) LET 73, Range: 253µm (Xe)  $V_{GS} = -10V, V_{DS} = 150V$  $V_{GS} = -15V, V_{DS} = 150V$   $V_{GS} = -20V, V_{DS} = 100V$ 

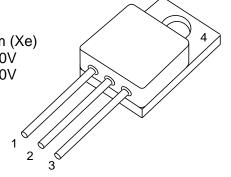
 $V_{GS} = -15V, V_{DS} = 80V$ 



- Hermetically sealed
- N-channel
- **C C** Space Qualified

ESA/SCC Detail Spec. No.: 5205/031

Type Variant No. 04



Туре	Marking	Pin Co	Package			
		1	2	3	4	
BUY15CS45B-01	-	D	S	G	Not connected	TO-254AA

### **Maximum Ratings**

Parameter	Symbol	Values	Unit
Drain Source Voltage	V <sub>DS</sub>	150	V
Gate Source Voltage	V <sub>GS</sub>	+/- 20	V
Drain Gate Voltage	$V_{DG}$	150	V
Continuous Drain Current $T_C = 25  ^{\circ}C$ $T_C = 100  ^{\circ}C$	I <sub>D</sub>	45 29	A
Continuous Source Current	Is	45	А
Drain Current Pulsed, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>DM</sub>	180	Apk
Total Power Dissipation 1)	P <sub>tot</sub>	208	W
Operating and Storage Temperature	T <sub>op</sub>	-55 to + 150	°C
Avalanche Energy	E <sub>AS</sub>	380	mJ

### **Thermal Characteristics**

Thermal Resistance (Junction to Case)	R <sub>th JC</sub>	0.6	K/W
Soldering Temperature	T <sub>sol</sub>	250	°C

### Notes.:

1) For  $T_S \le 25^{\circ}$ C. For  $T_S > 25^{\circ}$ C derating is required.

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Electrical Characteristics, at T <sub>A</sub> =25°C; unless otherwise specified					
Parameter	Symbol	Values	Unit		

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
DC Characteristics		•			•
Breakdown Voltage Drain to Source $I_D = 0.25$ mA, $V_{GS} = 0$ V	BV <sub>DSS</sub>	150	-	-	V
Temperature Coefficient of B <sub>VDSS</sub>	$\Delta BV_{DSS}/\Delta T_{J}$	-	0.20	-	V/°C
Gate Threshold Voltage I <sub>D</sub> = 1.0mA, V <sub>DS</sub> ≥ V <sub>GS</sub>	$V_{GS(th)}$	2.0	-	4.0	V
Gate to Source Leakage Current V <sub>DS</sub> = 0V, V <sub>GS</sub> = +/- 20V	I <sub>GSS</sub>	-	-	+/-100	nA
Drain Current V <sub>DS</sub> = 120V, V <sub>GS</sub> = 0V	I <sub>DSS</sub>	-	-	25	μΑ
Drain Source On Resistance 1) V <sub>GS</sub> = 10V, I <sub>D</sub> = 35A	R <sub>DS(ON)</sub>	-	23	27	mΩ
Source Drain Diode, Forward Voltage $^{1), 2)}$ $V_{GS} = 0V$ , $I_S = 45A$	V <sub>SD</sub>	-	-	1.4	V
AC Characteristics				•	•
Turn-on Delay Time $V_{DD} = 50\% V_{DS}, I_D = 35A, R_G = 4.7\Omega$	t <sub>d(ON)</sub>	-	25	45	ns
Rise Time $V_{DD} = 50\% V_{DS}$ , $I_D = 35A$ , $R_G = 4.7\Omega$	t <sub>r</sub>	-	35	95	ns
Turn-off Delay Time $V_{DD} = 50\% V_{DS}$ , $I_D = 35A$ , $R_G = 4.7\Omega$	t <sub>d(OFF)</sub>	-	50	60	ns
Fall Time $V_{DD} = 50\% V_{DS}$ , $I_D = 35A$ , $R_G = 4.7\Omega$	t <sub>f</sub>	-	20	100	ns
Reverse Recovery Time V <sub>DD</sub> < 50% V <sub>DS</sub> , I <sub>D</sub> = 45A	t <sub>rr</sub>	-	310	350	ns
Common Source Input Capacitance $V_{DS} = 100V$ , $V_{GS} = 0V$ , $f = 1.0MHz$	C <sub>iss</sub>	2.0	4.0	6.0	nF
Common Source Output Capacitance	C <sub>oss</sub>	360	480	600	pF

Common Source

Gate Resistance

**Total Gate Charge** 

 $V_{DS} = 100V, V_{GS} = 0V, f = 1.0MHz$ 

 $V_{DD} = 50\% \ V_{DS}, \ V_{GS} = 10V, \ I_D = 45A$ 

Reverse Transfer Capacitance  $V_{DS} = 100V, V_{GS} = 0V, f = 1.0MHz$ 

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 $C_{\text{rss}}$ 

 $R_{\text{\scriptsize G}}$ 

 $Q_{\mathsf{G}}$ 

60

83

8.0

75

100

100

рF

Ω

nC

Notes:
1) Pulsed Measurement: Pulse Width < 300µs, Duty Cycle <2.0%.
2) Measured within 2.0 mm of case.



### **Data Sheet** BUY15CS45B-01

### **Electrical Characteristics**

at T<sub>A</sub>=125°C; unless otherwise specified

Parameter	Symbol	Values		Unit	
		min.	max.		
DC Characteristics					
Gate Threshold Voltage $I_D = 1.0 \text{mA}, V_{DS} \ge V_{GS}$	$V_{GS(th)}$	1.5	-	V	
Gate to Source Leakage Current $V_{DS} = 0V$ , $V_{GS} = +/-20V$	I <sub>GSS</sub>	-	+/-200	nA	
Drain Current $V_{DS} = 120V$ , $V_{GS} = 0V$	I <sub>DSS</sub>	-	250	μΑ	
Drain Source On Resistance $^{1)}$ $V_{GS} = 10V$ , $I_D = 45A$	r <sub>DS(on)</sub>	-	53	mΩ	

### **Electrical Characteristics**

at T<sub>A</sub>=-55°C; unless otherwise specified

Parameter	Symbol	Values		Unit	
		min.	max.		
DC Characteristics					
Gate Threshold Voltage I <sub>D</sub> = 1.0mA, V <sub>DS</sub> ≥ V <sub>GS</sub>	V <sub>GS(th)</sub>	-	5.0	V	

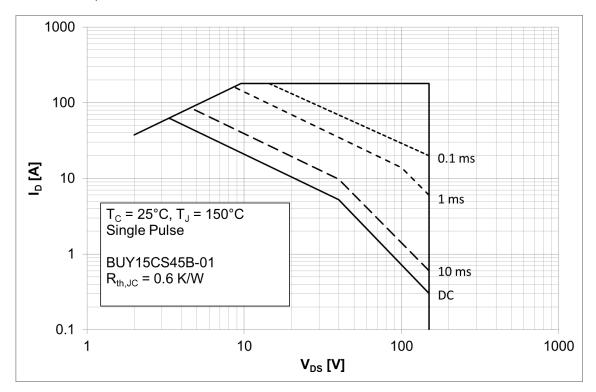
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Notes:
1) Pulsed Measurement: Pulse Width < 300µs, Duty Cycle <2.0%.

### 1 Safe operating area

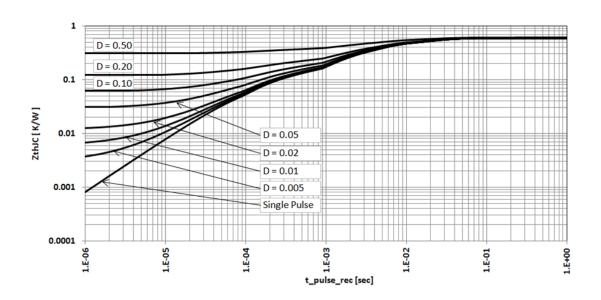
 $I_D = f(V_{DS}); T_C = 25^{\circ}C$ 

parameter: t<sub>p</sub>



### 2 Max. transient thermal impedance

 $Z_{thJC} = f(t_p)$ parameter:  $D = t_p/T$ 



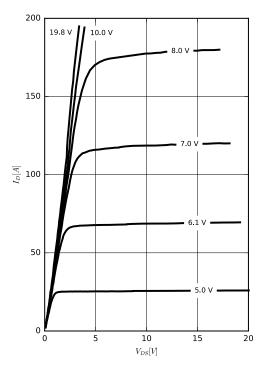


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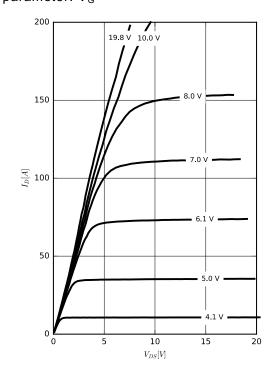
### 3 Typ. output characteristics

$$I_D = f(V_{DS}); T_j = 25 \text{ °C}$$
  
parameter:  $V_{GS}$ 



# 4 Typ. output characteristics

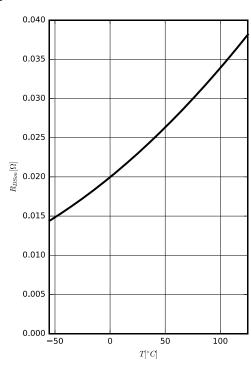
$$I_D = f(V_{DS}); T_j = 150 \, ^{\circ}C$$
 parameter:  $V_G$ 



# 5 Typ. drain-source on-state resistance

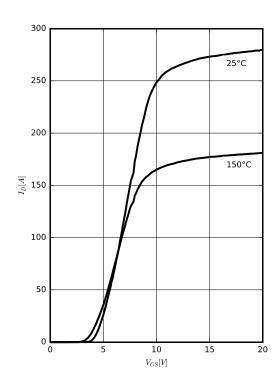
$$R_{DS(on)} = f(T_j)$$

$$I_D = 35A$$



### 6 Typ. transfer characteristics

$$I_D = f(V_{GS}); VDS = 10V$$
 parameter:  $T_i$ 



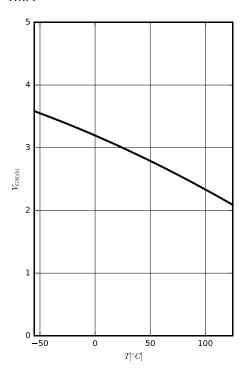


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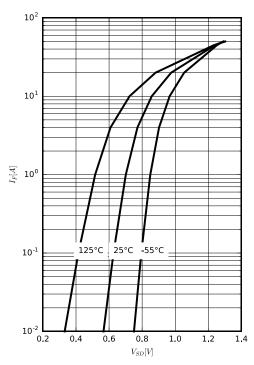
# 7 Typ. gate threshold voltage

$$I_D = f(T_j)$$
  
 $I_D = 1 \text{mA}$ 



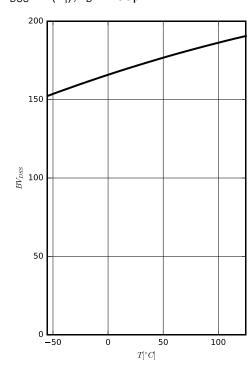
# 8 Typ. forward characteristics of reverse diode

 $I_F = f(V_{SD})$ ; parameter:  $T_i$ 



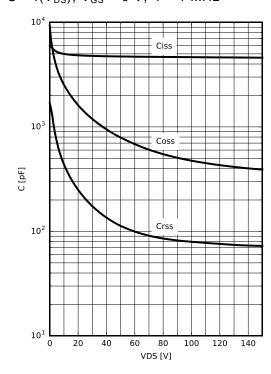
# 9 Typ. drain-source breakdown voltage

$$\mathsf{BV}_{\mathsf{DSS}} = \mathsf{f}(\mathsf{T_i}); \; \mathsf{I}_{\mathsf{D}} = 250 \mu \mathsf{A}$$



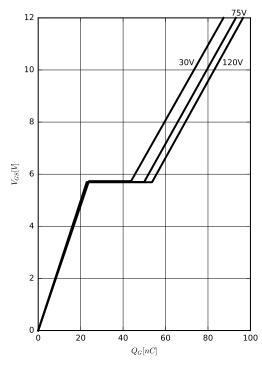
## 10 Typ. capacitances

$$C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$$

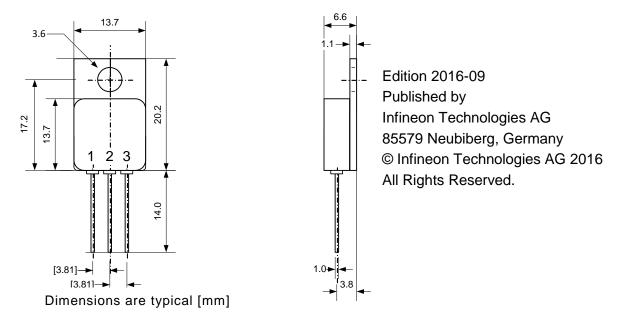


# 11 Typ. gate charge

 $V_{GS} = f(Q_{gate}); ID = 45.0 A pulsed parameter: <math>V_{DD}$ 



## TO-254AA Package



### Caution

This package contains beryllia. Therefore it must not be in any form machined, grinded, sanded, polished or any other mechanical operation which will produce dust and particles.

### **Attention please!**

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